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Controlling the nanomorphology of thin conformal Cu$_2$S overlayers
grown on Cu$_2$O compact layers and nanowires

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Abstract

Thin conformal Cu$_2$S overlayers are grown on Cu$_2$O compact layers (CLs) and nanowires (NWs) by ion exchange reaction (IER). This method is based on the exchange of O$_2^-$ into S$^{2-}$ ions at the surface of Cu$_2$O in a solution-containing Na$_2$S acting as the sulphur ions source. The Cu$_2$S overlayers are grown under different experimental conditions by varying the Na$_2$S concentration and the duration of the IER process, thus leading to different Cu$_2$S nanomorphologies. In particular, when a concentration of 2 mM Na$_2$S is used, hexagonal Cu$_2$S nanocrystals are formed on the surface of both Cu$_2$O CLs and NWs. These nanocrystals are of larger size at the ridges of the Cu$_2$O cubes in CLs and at the tips of Cu$_2$O in NWs. The high-quality crystal structure and composition of Cu$_2$S are confirmed by high resolution transmission electron spectroscopy and X-ray photoluminescence spectroscopy.

Keywords: Ion exchange reaction; nanomorphology; overlayer; copper oxide; copper sulfide.

1. Introduction

Nanostructured metal chalcogenides are attracting considerable attention due to their exceptional physical and chemical properties [1, 2]. Applications of these materials are as diverse as thermoelectrical systems, memories, energy conversion, and energy storage devices [3]. Cu$_2$S is a typical metal chalcogenide behaves is a p-type semiconductor with an indirect band gap $E_g$=1.2 eV. Depending on the preparation method, Cu$_2$S thin films can adopt variety morphologies such as nanowires [4], nanocages [5] or nanoparticles with different geometries [6]. Nanostructured Cu$_2$S is
used in lithium ion batteries [7], quantum dots solar cells as counter-electrodes [8] or photovoltaic devices [9]. Cu$_2$S can be prepared by atomic layer deposition [10], physical vapor deposition [11] or hydrothermal [12], among others.

Together with several other metal oxides [13-15] cuprous oxide Cu$_2$O is a promising material for photoelectrochemical (PEC) solar energy conversion [16]. In this work we report the preparation and nanomorphology of thin conformal Cu$_2$S overlayers grown on Cu$_2$O compact layers (CLs) and nanowires (NWs). The Cu$_2$S overlayers are grown via an ion exchange reaction (IER) consisting in the exchange of oxygen ions from Cu$_2$O with sulfur ions from Na$_2$S contained in an aqueous solution. The nanomorphology of the Cu$_2$S overlayers can be precisely controlled by adjusting the Na$_2$S concentration and the IER reaction time, and is independent of the starting Cu$_2$O morphology, either CLs or NWs.

2. Materials and methods

Cu$_2$O nanostructures are fabricated as CLs by electrodeposition (see Electronic Supplementary Material ESM†, Section 1.1) and as NWs by anodization (ESM† Section 1.2). Then Cu$_2$O CLs and NWs (Fig. S1) are used for growing Cu$_2$S overlayers by IER. Different Cu$_2$O samples are immersed in 2 mM and 5 mM Na$_2$S solutions during different times at 80 °C (ESM†, Section 1.3). All materials are analyzed by scanning electron microscopy (SEM, Jeol JSM-6700F) and high-resolution transmission electron microscopy (HR-TEM, JEM-2010). The HR-TEM analysis is carried out on the samples in powder form. Absolute ethanol is added to the powder in a 10 ml bottle and deposited three drops at intervals of 5 minutes on copper grids. X-ray photoelectron spectroscopy (XPS) was performed under monochromatic Al Kα radiation (hv=1486.7 eV) was used at 300 W, 14 kV under ultra-high vacuum.

3. Results and discussion

3.1 Morphology of the Cu$_2$S overlayers

When carried out during 15 minutes in a 2 mM solution, the IER growth of Cu$_2$S is slow (Fig 1a,b). It induces the formation of a homogeneous layer of nanostructured Cu$_2$S crystals all over the surface of the Cu$_2$O CLs (Fig. 1a). The Cu$_2$S nanocrystals grow preferentially on the ridges of the cubic Cu$_2$O structures (Fig. 1b,c). These crystals are of larger size than those growing on the faces of the Cu$_2$O cubes (Fig. 1d). As expected the Cu$_2$S nanocrystals are hexagonal in shape. A longer IER duration time up to 60 minutes does not affect drastically the morphology of the Cu$_2$S overlayer (Fig. 1e), although a thickening of the Cu$_2$S crystals on the ridges progressively takes place due to an
increasing overlap of the crystals (Fig. 1f). Besides, when the Na$_2$S concentration is increased up to 5 mM, the Cu$_2$S growth kinetics is faster and takes place in only 2 minutes (Fig. 1g). The Cu$_2$S overlayer is also very homogeneous, although there are no nanostructures formed on the surface (Fig. 1h,i). A perpendicular cross-arrangement of the constitutive Cu$_2$S nanocrystals is clearly observed that is similar to that observed in a 2 mM Na$_2$S solution after 15 minutes (Fig. 1d). Finally, when Cu$_2$O is immersed in a 2 mM solution, adhesion of the Cu$_2$S overlayer on Cu$_2$O CLs is excellent, thus making potential applications realistic. However, we note that adhesion of the Cu$_2$S overlayer is reduced when using a higher Na$_2$S concentration of 5 mM, thus leading to partial detachment of the Cu$_2$S overlayer.

Fig. 1 SEM micrographs of Cu$_2$O compact layers (CLs) coated with a Cu$_2$S overlayer prepared by IER under different Na$_2$S concentrations and reaction times. Magnifications of the Cu$_2$S nanocrystals inside the white squares are shown on the right images.

IER has been also conducted on Cu$_2$O NWs in solutions containing Na$_2$S concentrations of respectively 2 mM and 5 mM. After 30 minutes of IER in a 2 mM solution an overlayer of Cu$_2$S nanocrystals grows around the NWs (Fig. 2a). The morphology of the Cu$_2$S layer (Fig. 2b) is comparable to that obtained in similar conditions on CLs (Fig. 1b,e). Noticeably, larger Cu$_2$S
nanostructures grow on the Cu\textsubscript{2}O NWs tips, a phenomenon which is reminiscent of the higher concentration of Cu\textsubscript{2}S nanocrystals on the Cu\textsubscript{2}O CLs ridges \textit{(vide supra)}. On the other hand, when the IER process is carried out in a 5 mM solution, the Cu\textsubscript{2}S overlayer is not nanostructured (Fig. 2c) although the Cu\textsubscript{2}S crystal structure formed after 5 minutes is still visible (Fig. 2d). This morphology resembles that of the Cu\textsubscript{2}S-coated Cu\textsubscript{2}O CLs grown into a 5 mM solution (see Fig. 1h,i). However, in contrast to Cu\textsubscript{2}S overlayers grown on CLs using a 5 mM Na\textsubscript{2}S concentration, the Cu\textsubscript{2}S overlayers grown on NWs in 5 mM solutions exhibit a very good adhesion to Cu\textsubscript{2}O.

![Fig. 2 SEM micrographs of Cu\textsubscript{2}O nanowires (NWs) coated by a Cu\textsubscript{2}S overlayer prepared an IER process under different Na\textsubscript{2}S concentrations and reaction times.](image)

### 3.2 High resolution transmission electron microscopy (HR-TEM)

Images in Fig. 3a,b correspond to Cu\textsubscript{2}S-coated Cu\textsubscript{2}O samples for respectively a CLs and NWs. In both images dark and bright areas are observed. The selected regions delimited by white squares are analysed by fast Fourier transform (FFT). Fig. 3c represents the FFT performed in the selected region of the brighter area of a CL. It reveals lattice spacing of 3.19, 2.78 and 1.96 Å which can be attributed to the (111), (200) and (220) planes of Cu\textsubscript{2}S. In the FFT of the selected region in darker area (Fig. 3d), three lattice spacing of 2.45, 2.13 and 1.50 Å are observed that can be attributed respectively to the crystallographic planes (111), (200) and (220) of Cu\textsubscript{2}O. The FFT analysis of the bright selected area of
the NWs (Fig. 3e) reveals an interplanar distance of 1.96 Å corresponding to the (220) plane of Cu$_2$S. It also unveils the (200) plane corresponding to Cu$_2$O with an interplanar distance of 2.13 Å. The crystallographic planes of Cu$_2$O are also observed very clearly in the FFT of the region in the darker area (Fig. 3f).

![HR-TEM images of Cu$_2$S-coated Cu$_2$O a) CLs and b) NWs. c,d,e,f) FFT analysis of the selected regions in either dark or bright contrast (white squares)](image)

3.3 X-ray photoluminescence spectroscopy (XPS)

We performed X-ray photoelectron spectroscopy (XPS) in order to confirm the formation of Cu$_2$S (Fig. 4). In the wide XPS spectra are shown the Cu 2p, Cu LMM, O 1s, C 1s and S 2p for both CLs and NWs (Fig. 4a,b). We can observe the Cu 2p$_{3/2}$ peak at 952.5 eV and the Cu 2p$_{1/2}$ peak at 932.6 eV (Fig. 4c) showing that the oxidation state of copper species correspond to Cu$^+$. We have seen no satellite peaks of Cu 2p$_{3/2}$ and Cu 2p$_{1/2}$ which is an evidence of the absence of Cu$^{2+}$ oxidation state on the surface of the overlayers on CLs and NWs. For both CLs and NWs the S 2p regions (Fig. 4d) show the characteristic shape of an S$^2-$ band. Peaks at 162.9 eV and 161.8 eV can be attributed to the S 2p$_{3/2}$ and S 2p$_{1/2}$ spin-orbit doublet.
4. Conclusion

The influence of the concentration of Na$_2$S solution is a critical parameter for the growth of the Cu$_2$S overlayers on Cu$_2$O compact layers and nanowires by ion exchange reaction. When a concentration of 2 mM Na$_2$S is used, hexagonal Cu$_2$S nanocrystals are formed on the surface of both Cu$_2$O CLs and NWs. The sizes of the crystals are bigger at the ridges of the Cu$_2$O cubes in CLs and the tips of Cu$_2$O in NWs. The time scale of the IER process does not affect much the Cu$_2$S morphology although larger clusters of Cu$_2$S nanocrystals are formed at the ridges of the CLs. HR-TEM confirms the formation of the Cu$_2$S single crystals while XPS reveals the high-quality chemical composition of the overlayers. We are presently using these conformal Cu$_2$S overlayers to protect Cu$_2$O electrodes during photoelectrochemical experiments that will be reported elsewhere [17].

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References


**Highlights**
- Conformal layers of Cu$_2$S on Cu$_2$O are grown by ion exchange reaction.
- The morphology of the Cu$_2$S overlayers is not dictated by the morphology of the starting Cu$_2$O material.
- Different Cu$_2$S nanomorphologies are studied by SEM, HRTEM and XPS.
- Cu$_2$S overlayers have a potential application as protection against photodecomposition of Cu$_2$O photoelectrodes.